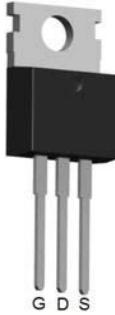
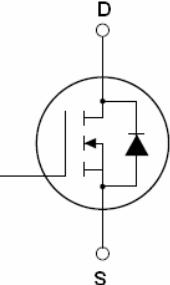


## N-Channel Trench Power MOSFET

<p><b>General Description</b></p> <p>The CS85105A is SGT MOSFET designed for high current switching applications. Rugged EAS capability and ultra low <math>R_{DS(ON)}</math> is suitable for PWM, load switching applications.</p> <p><b>Features</b></p> <ul style="list-style-type: none"> <li>● <math>V_{DS}=80V</math>; <math>I_D=82A</math> @ <math>V_{GS}=10V</math>; <math>R_{DS(ON)}&lt;6.8m\Omega</math> @ <math>V_{GS}=10V</math></li> <li>● Ultra Low On-Resistance</li> <li>● High UIS and UIS 100% Test</li> </ul> <p><b>Application</b></p> <ul style="list-style-type: none"> <li>● Hard Switched and High Frequency Circuits</li> <li>● Uninterruptible Power Supply</li> </ul>	 <b>To-220 Top View</b>	 <b>Schematic Diagram</b>
	$V_{DS} = 80 V$ $I_D = 82A$ $R_{DS(ON)} = 5.5m\Omega$	

### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
CS85105A	CS85105A	TO-220	-	-	-

**Table 1. Absolute Maximum Ratings (TA=25°C)**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-Source Voltage ( $V_{GS}=0V$ )	83	V
$V_{GS}$	Gate-Source Voltage ( $V_{DS}=0V$ )	$\pm 20$	V
$I_D$ (DC)	Drain Current (DC) at $T_c=25^\circ C$	82	A
$I_D$ (DC)	Drain Current (DC) at $T_c=100^\circ C$	57	A
$I_{DM}$ (pulse)	Drain Current-Continuous@ Current-Pulsed <sup>(Note 1)</sup>	328	A
$P_D$	Maximum Power Dissipation( $T_c=25^\circ C$ )	99	W
	Derating Factor	0.66	W/°C
$E_{AS}$	Single Pulse Avalanche Energy <sup>(Note 2)</sup>	625	mJ
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 To 175	°C

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2.EAS condition: $T_J=25^\circ C, V_{DD}=40V, V_G=10V, R_G=25 \Omega$

**Table 2. Thermal Characteristic**

Symbol	Parameter	Value	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	---	1.51	°C/W

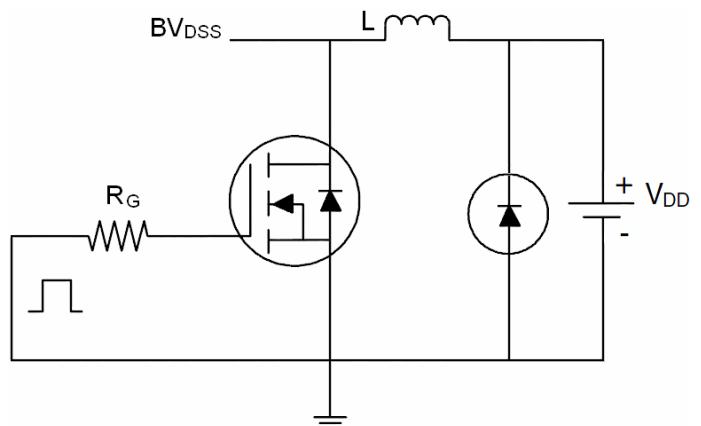
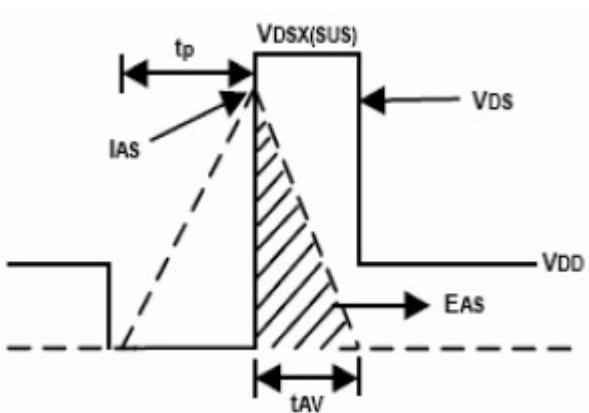
**Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>On/Off States</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	83			V
$I_{DSS}$	Zero Gate Voltage Drain Current(Tc=25°C)	$V_{DS}=83V, V_{GS}=0V$			1	$\mu A$
$I_{DSs}$	Zero Gate Voltage Drain Current(Tc=125°C)	$V_{DS}=83V, V_{GS}=0V$			10	$\mu A$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2		4	V
$R_{DS(ON)}$	Drain-Source On-State Resistance	$V_{GS}=10V, I_D=40A$		5.5	6.8	$m\Omega$
<b>Dynamic Characteristics</b>						
$g_{FS}$	Forward Transconductance	$V_{DS}=10V, I_D=15A$	20			S
$C_{iss}$	Input Capacitance	$V_{DS}=25V, V_{GS}=0V, f=1.0MHz$		3016		PF
$C_{oss}$	Output Capacitance			1051		PF
$C_{rss}$	Reverse Transfer Capacitance			106		PF
$Q_g$	Total Gate Charge	$V_{DS}=20V, I_D=5A, V_{GS}=10V$		47		nC
$Q_{gs}$	Gate-Source Charge			14.6		nC
$Q_{gd}$	Gate-Drain Charge			12		nC
<b>Switching Times</b>						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=30V, I_D=40A, R_L=15\Omega$ $V_{GS}=10V, R_G=2.5\Omega$		15		nS
$t_r$	Turn-on Rise Time			32.3		nS
$t_{d(off)}$	Turn-Off Delay Time			24		nS
$t_f$	Turn-Off Fall Time			15		nS
<b>Source-Drain Diode Characteristics</b>						
$I_{SD}$	Source-drain Current(Body Diode)			82		A
$I_{SDM}$	Pulsed Source-Drain Current(Body Diode)			328		A
$V_{SD}$	Forward On Voltage <sup>(Note 1)</sup>	$T_J=25^\circ C, I_{SD}=40A, V_{GS}=0V$		0.9	0.99	V
$t_{rr}$	Reverse Recovery Time <sup>(Note 1)</sup>	$T_J=25^\circ C, I_F=30A$ $dI/dt=100A/\mu s$		45		nS
$Q_{rr}$	Reverse Recovery Charge <sup>(Note 1)</sup>			80		nC
$t_{on}$	Forward Turn-on Time	Intrinsic turn-on time is negligible(turn-on is dominated by $L_S+L_D$ )				

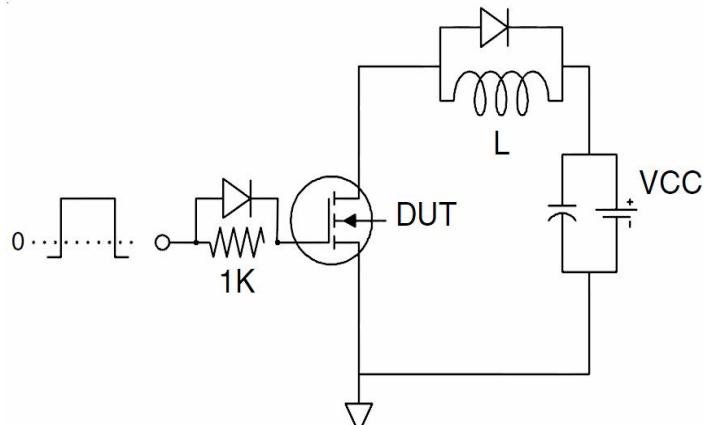
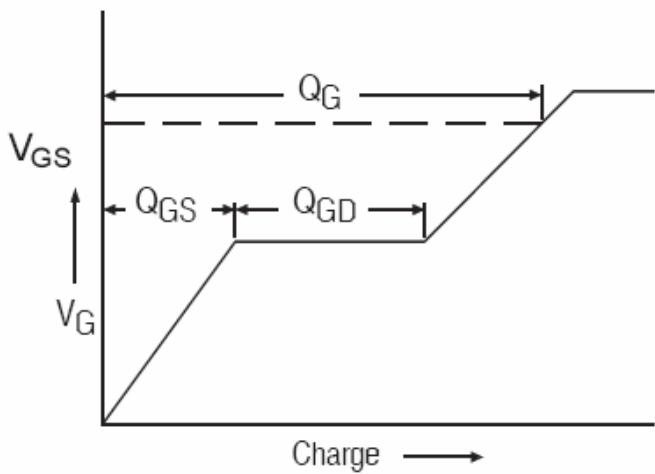
Notes 1.Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 1.5\%$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ C$

## Test Circuit

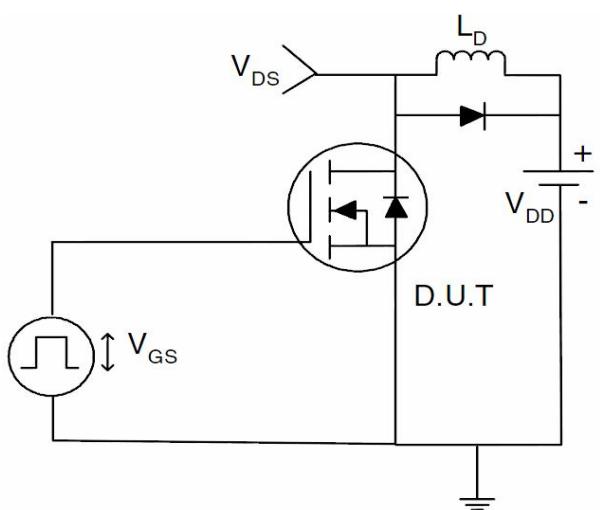
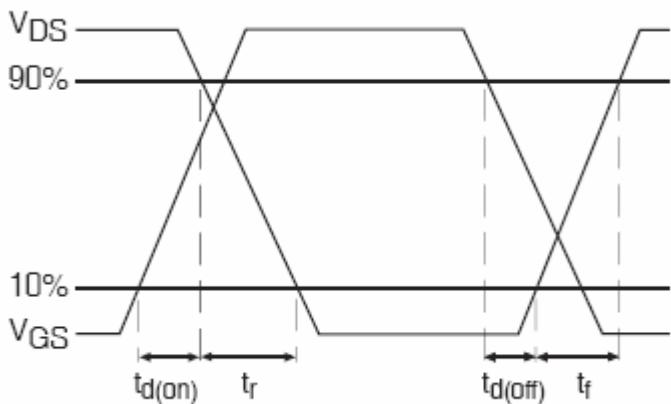
### 1) E<sub>AS</sub> Test Circuits



### 2) Gate Charge Test Circuit:

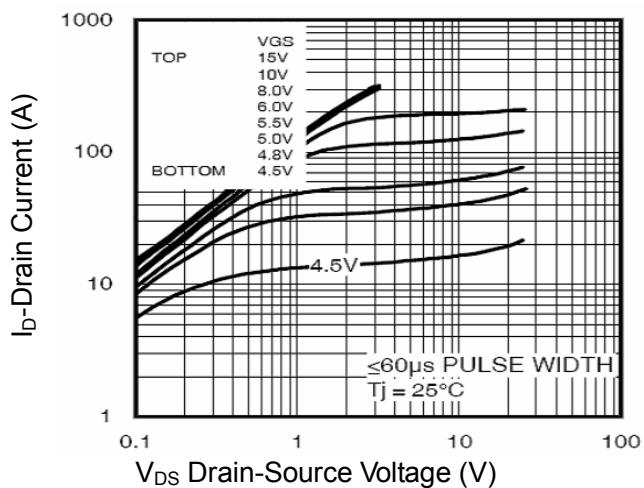


### 3) Switch Time Test Circuit:

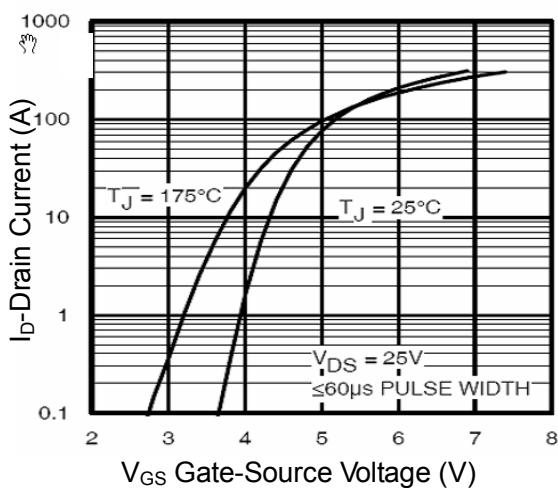


## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)

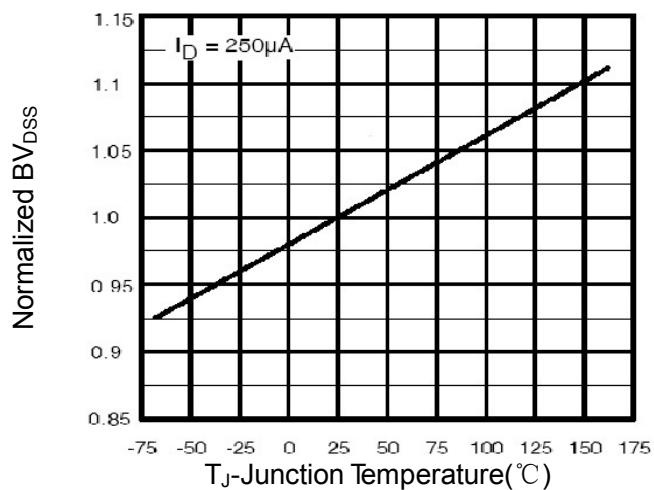
**Figure1. Output Characteristics**



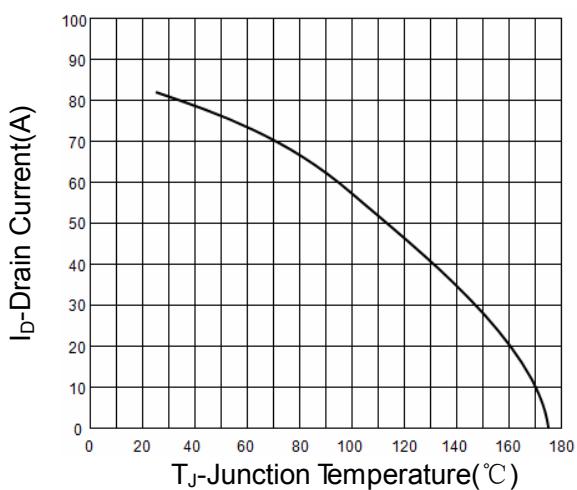
**Figure2. Transfer Characteristics**



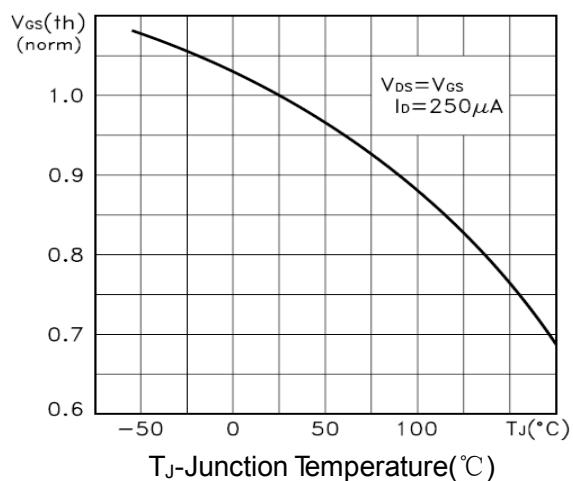
**Figure3. BVDSS vs Junction Temperature**



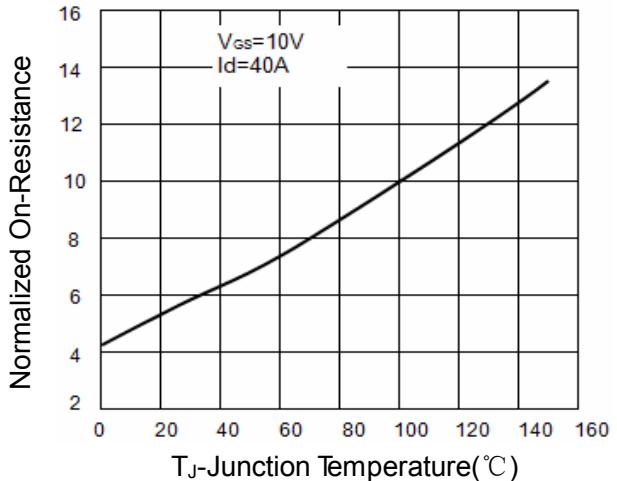
**Figure4. ID vs Junction Temperature**



**Figure5. VGS(th) vs Junction Temperature**



**Figure6. Rdson Vs Junction Temperature**



**Figure7. Gate Charge**

**Figure8. Capacitance vs Vds**

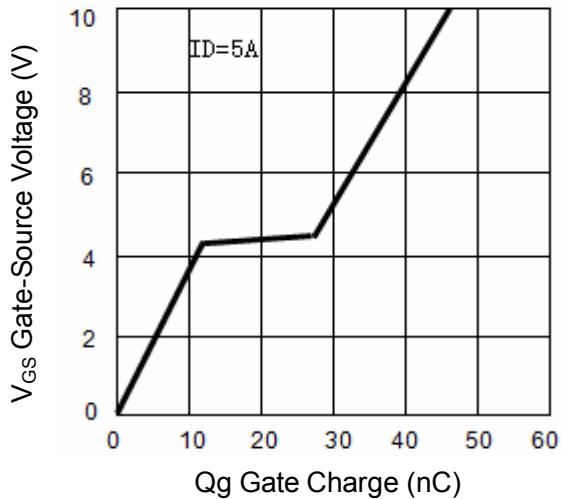


Figure9. Source- Drain Diode Forward

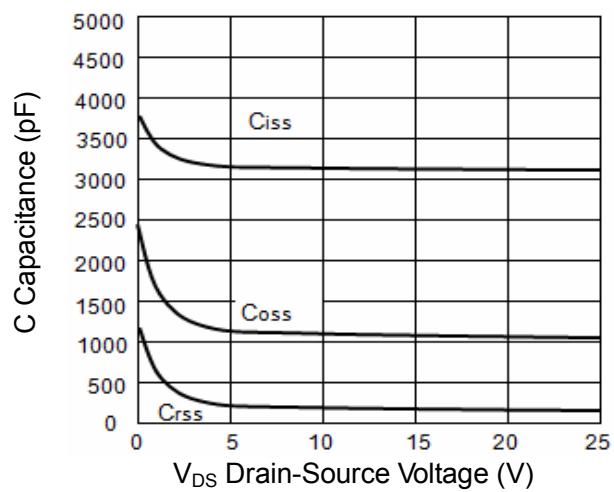
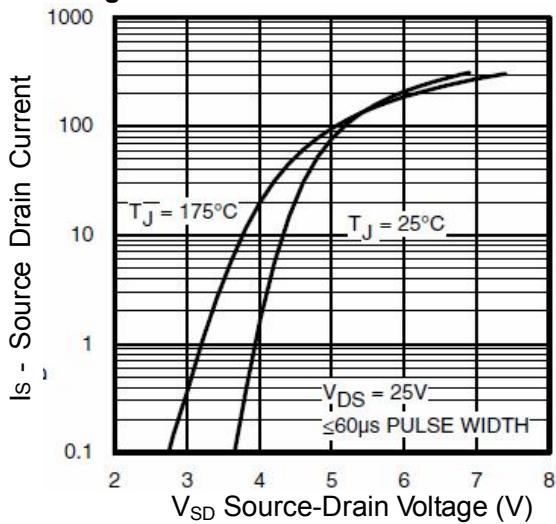


Figure10. Safe Operation Area

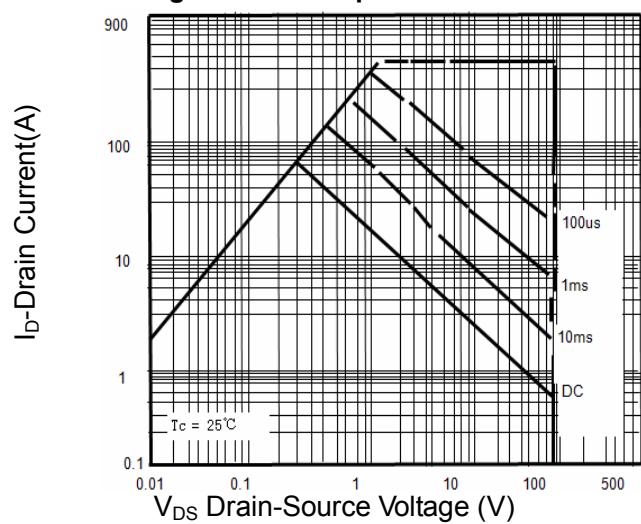
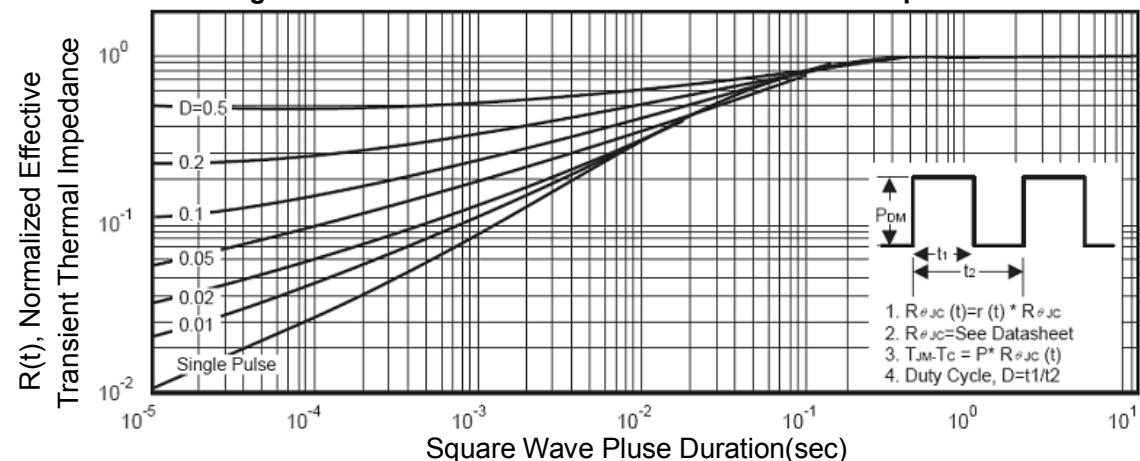


Figure11. Normalized Maximum Transient Thermal Impedance



<b>Symbol</b>	<b>Dimensions In Millimeters</b>		<b>Dimensions In Inches</b>	
	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max</b>
A	4.300	4.700	0.169	0.185
A1	2.200	2.600	0.087	0.102
b	0.700	0.950	0.028	0.037
b1	1.170	1.410	0.046	0.056
c	0.450	0.650	0.018	0.026
c1	1.200	1.400	0.047	0.055
D	9.600	10.400	0.378	0.409
E	8.8500	9.750	0.348	0.384
E1	12.650	12.950	0.498	0.510
e	2.540 TYP.		0.100TYP.	
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
H	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.750	14.300	0.502	0.563
L1	2.850	3.950	0.112	0.156
V	7.500 REF.		0.295 REF.	
Φ	3.400	4.000	0.134	0.157